

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







BGA736L16

Tri-Band HSDPA LNA (2100, 1900/2100, 800/900 MHz)

RF & Protection Devices



Edition 2008-07-03

Published by Infineon Technologies AG 81726 München, Germany © Infineon Technologies AG 2009. All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies Components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.





BGA736L16

Revision History: 2008-07-03, V2.1

Previous Version: 2008-02-27, V2.0

Previous	Previous Version: 2008-02-27, V2.0							
Page	Subjects (major changes since last revision)							
5, 6	Updated HBM ESD protection							
11	Added RF characteristics for UMTS band VIII							
13	Added RF characteristics for UMTS band IV							
39	Added application circuit schematic for UMTS bands I, IV and VIII							
all	Updated values for high and mid gain currents							

Data Sheet 3 V2.1, 2008-07-03



Table of Contents

	Table of Contents	. 4
1	Description	. 5
2	Electrical Characteristics	. 6
2.1	Absolute Maximum Ratings	. 6
2.2	Thermal Resistance	. 6
2.3	ESD Integrity	. 6
2.4	DC Characteristics	. 7
2.5	Band Select / Gain Control Truth Table	. 7
2.6	Supply current characteristics; $T_{\rm A}$ = 25 °C	. 8
2.7	Logic Signal Characteristics; $T_{\rm A}$ = 25 °C	. 9
2.8	Switching Times	
2.9	Measured RF Characteristics Low Band	10
2.9.1	Measured RF Characteristics UMTS Band V	
2.9.2	Measured RF Characteristics UMTS Band VIII	
2.10	Measured RF Characteristics Mid Band	
2.10.1	Measured RF Characteristics UMTS Band II	
2.10.2	Measured RF Characteristics UMTS Band IV	
2.11	Measured RF Characteristics High Band	
2.11.1	Measured RF Characteristics UMTS Band I	
2.12	Measured Performance Low Band High Gain Mode vs. Frequency	
2.13	Measured Performance Low Band High Gain Mode vs. Temperature	
2.14	Measured Performance Low Band Mid Gain Mode vs. Frequency	
2.15	Measured Performance Low Band Mid Gain Mode vs. Temperature	
2.16	Measured Performance Low Band Low Gain Mode vs. Frequency	
2.17	Measured Performance Low Band Low Gain Mode vs. Temperature	
2.18	Measured Performance Mid Band High Gain Mode vs. Frequency	
2.19	Measured Performance Mid Band High Gain Mode vs. Temperature	
2.20	Measured Performance Mid Band Mid Gain Mode vs. Frequency	
2.21	Measured Performance Mid Band Mid Gain Mode vs. Temperature	
2.22	Measured Performance Mid Band Low Gain Mode vs. Frequency	
2.23	Measured Performance Mid Band Low Gain Mode vs. Temperature	
2.24 2.25	Measured Performance High Band High Gain Mode vs. Frequency	
2.25 2.26	Measured Performance High Band High Gain Mode vs. Temperature	
2.20 2.27		
2.2 <i>1</i> 2.28	Measured Performance High Band Mid Gain Mode vs. Temperature	
2.20 2.29	Measured Performance High Band Low Gain Mode vs. Frequency	
	•	
3	Application Circuit and Block Diagram	
3.1	UMTS bands I, II and V Application Circuit Schematic	
3.2	UMTS bands I, IV and VIII Application Circuit Schematic	
3.3	Pin Definition	
3.4	Application Board	41
4	Physical Characteristics	43
4.1	Package Footprint	
4.2	Package Dimensions	



1 Description

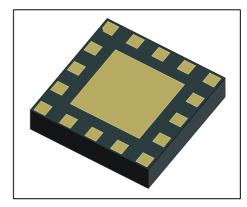
The BGA736L16 is a highly flexible, tri-gain mode, and tri-band (2100, 1900/2100, 800/900 MHz) MMIC low noise amplifier for worldwide use. Based on Infineon's proprietary and cost-effective SiGe:C technology, the BGA736L16 features dynamic gain control, temperature stabilization, standby mode, and 2 kV ESD protection on-chip and matching off chip.

While two gain modes are common in W-CDMA systems, a third gain mode has been introduced to reduce the LNA gain just enough to pass adjacent channel tests without compromising on HSDPA performance. The 1900 MHz path can be converted into a 2100 MHz path and vice versa by optimizing the input matching and using an additional external output matching network. This document specifies device performance for the band combinations - UMTS bands I / II / V and UMTS bands I / IV / VIII.

Features

- Gain: 16 / 3 / -8 dB in high / mid / low gain mode
- Noise figure: 1.1 dB in high gain mode
- Supply current: 5.3 / 5.3 / 0.85 mA in high / mid / low gain modes
- Standby mode current consumption < 2 μA
- Outputs internally matched to 50 Ω
- 2 kV HBM ESD protection
- Low external component count
- Small leadless TSLP-16-1 package (2.3 x 2.3 x 0.39 mm)
- Pb-free (RoHS compliant) package





TSLP-16-1 package

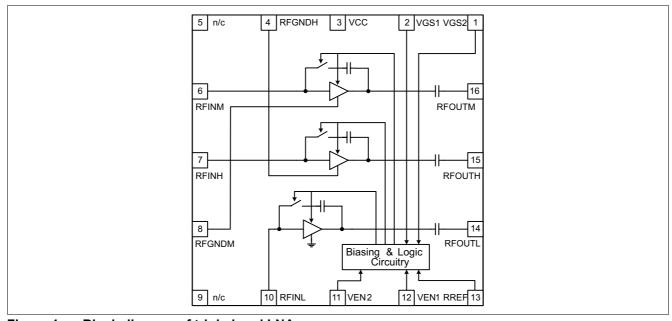


Figure 1 Block diagram of triple-band LNA

Туре	Package	Marking	Chip
BGA736L16	PG-TSLP-16-1	BGA736	T1540

Data Sheet 5 V2.1, 2008-07-03



Absolute Maximum Ratings

2 Electrical Characteristics

2.1 Absolute Maximum Ratings

Table 1 Absolute Maximum Ratings

Parameter	Symbol	Values		Unit	Note / Test Condition
		Min.	Max.		
Supply voltage	$V_{\sf CC}$	-0.3	3.6	V	
Supply current	$I_{\sf CC}$		10	mA	
Pin voltage	V_{PIN}	-0.3	V _{CC} +0.3	V	All pins except RF input pins
Pin voltage RF input pins	V_{RFIN}	-0.3	0.9	V	
RF input power	P_{RFIN}		4	dBm	
Junction temperature	T_{i}		150	°C	
Ambient temperature range	T_{A}	-30	85	°C	
Storage temperature range	T_{STG}	-65	150	°C	

2.2 Thermal Resistance

Table 2 Thermal Resistance

Parameter	Symbol	Value	Unit	Note / Test Conditions
Thermal resistance junction	R_{thJS}	≤ 110	K/W	
to soldering point				

2.3 ESD Integrity

Table 3 ESD Integrity

Parameter	Symbol	Value	Unit	Note / Test Conditions
		Тур.		
ESD hardness HBM ¹⁾	$V_{ESD-HBM}$	2000	V	All pins

¹⁾ According to JESD22-A114

Data Sheet 6 V2.1, 2008-07-03



DC Characteristics

2.4 DC Characteristics

Table 4 DC Characteristics, $T_A = 25$ °C

Parameter	Symbol	Values			Unit	Note / Test Condition	
		Min.	Тур.	Max.			
Supply voltage	$V_{\sf CC}$	2.7	2.8	3.0	V		
Supply current high and mid	I_{CCHG}					All bands	
gain mode	I_{CCMG}					Supply current is	
-30°C			4.3		mA	proportional to absolute	
25°C			5.3		mA	temperature	
85°C			6.4		mA		
Supply current low gain	I_{CCLG}		850		μΑ	All bands	
mode							
Supply current standby	I_{CCOFF}		0.1	2	μΑ		
mode							
Logic level high	V_{HI}	1.5	2.8		V	VEN1 and VEN2	
Logic level low	V_{LOW}		0.0	0.5	V		
Logic currents VEN	I_{ENL}		0.2		μΑ	VEN1 and VEN2	
	I_{ENH}		10.0		μΑ		
Logic currents VGS	I_{GSL}		0.1		μΑ	VGS	
	I_{GSH}		5.0		μΑ		

2.5 Band Select / Gain Control Truth Table

Table 5 Band Select Truth Table, V_{cc} = 2.8 V

	High band	Mid band	Low band	Standby mode
VEN1	Н	Н	L	L
VEN2	Н	L	Н	L

Table 6 Gain Control Truth Table, $V_{\rm CC}$ = 2.8 V

	High Gain	Mid Gain	Low Gain
VGS1	Н	Н	L
VGS2	L	Н	L

Data Sheet 7 V2.1, 2008-07-03

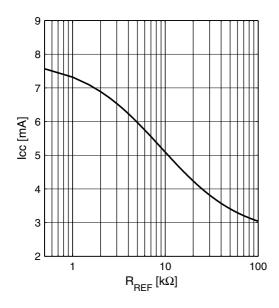


Supply current characteristics; $T_A = 25$ °C

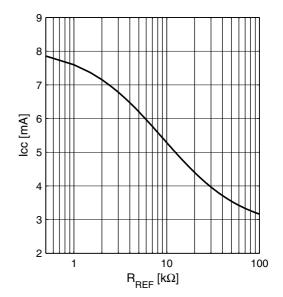
2.6 Supply current characteristics; $T_A = 25$ °C

Supply current high / mid gain mode versus reference resistor R_{REF} (see **Figure 2 on page 38** for reference resistor; low gain mode supply current is independent of reference resistor).

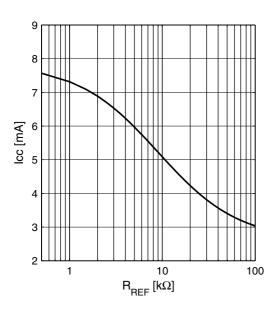
Supply Current Highband
$$I_{\rm CC}\,$$
 = f $(R_{\rm REF})$ $V_{\rm CC}$ = 2.8 V



Supply Current Midband
$$I_{\rm CC}$$
 = f ($R_{\rm REF}$) $V_{\rm CC}$ = 2.8 V



Supply Current Lowband $I_{\rm CC}$ = f ($R_{\rm REF}$) $V_{\rm CC}$ = 2.8 V

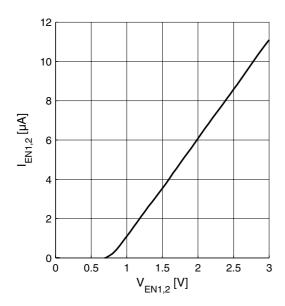


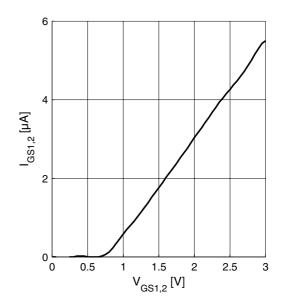


Logic Signal Characteristics; $T_A = 25$ °C

2.7 Logic Signal Characteristics; $T_A = 25$ °C

Current consumption of logic inputs VEN1, VEN2, VGS1, VGS2





2.8 Switching Times

Table 7 Typical switching times; $T_A = -30 \dots 85 \,^{\circ}\text{C}$

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Тур.	Max.		
Settling time gainstep	t_{GS}		1		μs	Switching from any gain mode to a different gain mode; all bands
Settling time bandselect	t_{BS}		1.6		μs	Switching from any band to a different band; all gain modes

Data Sheet 9 V2.1, 2008-07-03



Measured RF Characteristics Low Band

2.9 Measured RF Characteristics Low Band

2.9.1 Measured RF Characteristics UMTS Band V

Table 8 Typical Characteristics 800 MHz Band, $T_{\rm A}$ = 25 °C, $V_{\rm CC}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Тур.	Max.		
Pass band range		869		894	MHz	
Current consumption	I_{CCHG}		5.20		mA	High gain mode
	I_{CCMG}		5.20		mA	Mid gain mode
	I_{CCLG}		0.85		mA	Low gain mode
Gain	$S_{ m 21HG}$		15.5		dB	High gain mode
	$S_{ m 21MG}$		3.0		dB	Mid gain mode
	S_{21LG}		-8.9		dB	Low gain mode
Reverse Isolation ¹⁾	$S_{ m 12HG}$		-38		dB	High gain mode
	S_{12MG}		-40		dB	Mid gain mode
	S_{12LG}		-9		dB	Low gain mode
Noise figure	NF_{HG}		1.1		dB	High gain mode
	NF_{MG}		2.4		dB	Mid gain mode
	NF_{LG}		9.0		dB	Low gain mode
Input return loss ¹⁾	S_{11HG}		-14		dB	50 Ω, high gain mode
	S_{11MG}		-12		dB	50 Ω, mid gain mode
	$S_{ t 11LG}$		-10		dB	50 Ω, low gain mode
Output return loss ¹⁾	$S_{22\mathrm{HG}}$		-20		dB	50 Ω, high gain mode
	$S_{ m 22MG}$		-22		dB	50 Ω, mid gain mode
	$S_{ m 22LG}$		-18		dB	50 Ω , low gain mode
Stability factor ²⁾	k		>3.1			DC to 10 GHz; all gain modes
Input compression point1)	IP_{1dBHG}		-11		dBm	High gain mode
	IP_{1dBMG}		-10		dBm	Mid gain mode
	IP_{1dBLG}		-12		dBm	Low gain mode
Inband IIP31)	IIP3 _{HG}		-5		dBm	High gain mode
$f_1 - f_2 = 1 \text{ MHz}$	$IIP3_{MG}$		-5			Mid gain mode
$P_{\rm f1} = P_{\rm f2} = -25 \text{ dBm}$	IIP3 _{LG}		-3			Low gain mode

¹⁾ Verified by random sampling; not 100% RF tested

Data Sheet 10 V2.1, 2008-07-03

²⁾ Not tested in production; guaranteed by device design



Measured RF Characteristics Low Band

2.9.2 Measured RF Characteristics UMTS Band VIII

Table 9 Typical Characteristics 900 MHz Band, $T_{\rm A}$ = 25 °C, $V_{\rm CC}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

Parameter	Symbol		Values	3	Unit	Note / Test Condition
		Min.	Тур.	Max.		
Pass band range		925		960	MHz	
Current consumption	I_{CCHG}		5.20		mA	High gain mode
	I_{CCMG}		5.20		mA	Mid gain mode
	I_{CCLG}		0.85		mA	Low gain mode
Gain	$S_{ m 21HG}$		15.2		dB	High gain mode
	$S_{ m 21MG}$		2.8		dB	Mid gain mode
	$S_{ m 21LG}$		-8.8		dB	Low gain mode
Reverse Isolation ¹⁾	$S_{ m 12HG}$		-37		dB	High gain mode
	S_{12MG}		-39		dB	Mid gain mode
	$S_{ m 12LG}$		-9		dB	Low gain mode
Noise figure	NF_{HG}		1.2		dB	High gain mode
	NF_{MG}		2.6		dB	Mid gain mode
	NF_{LG}		9.0		dB	Low gain mode
Input return loss1)	S_{11HG}		-14		dB	50 Ω, high gain mode
	S_{11MG}		-12		dB	50 Ω, mid gain mode
	$S_{ exttt{11LG}}$		-11		dB	50 Ω, low gain mode
Output return loss ¹⁾	$S_{ m 22HG}$		-20		dB	50 Ω, high gain mode
	$S_{ m 22MG}$		-19		dB	50 Ω, mid gain mode
	$S_{ m 22LG}$		-19		dB	50 Ω, low gain mode
Stability factor ²⁾	k		>3.4			DC to 10 GHz; all gain modes
Input compression point1)	IP_{1dBHG}		-9		dBm	High gain mode
	IP_{1dBMG}		-5		dBm	Mid gain mode
	IP_{1dBLG}		-11		dBm	Low gain mode
Inband IIP31)	IIP3 _{HG}		-5		dBm	High gain mode
$f_1 - f_2 = 1 \text{ MHz}$	$IIP3_{MG}$		-5			Mid gain mode
$P_{\rm f1} = P_{\rm f2} = -25 \text{ dBm}$	$IIP3_{LG}$		-3			Low gain mode

¹⁾ Verified by random sampling; not 100% RF tested

Data Sheet 11 V2.1, 2008-07-03

²⁾ Not tested in production; guaranteed by device design



Measured RF Characteristics Mid Band

2.10 Measured RF Characteristics Mid Band

2.10.1 Measured RF Characteristics UMTS Band II

Table 10 Typical Characteristics 1900 MHz Band, $T_{\rm A}$ = 25 °C, $V_{\rm CC}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

Parameter	Symbol		Values	3	Unit	Note / Test Condition
		Min.	Тур.	Max.		
Pass band range		1930		1990	MHz	
Current consumption	I_{CCHG}		5.30		mA	High gain mode
	I_{CCMG}		5.30		mA	Mid gain mode
	I_{CCLG}		0.85		mA	Low gain mode
Gain	$S_{ m 21HG}$		16.1		dB	High gain mode
	$S_{ m 21MG}$		2.7		dB	Mid gain mode
	S_{21LG}		-8.1		dB	Low gain mode
Reverse Isolation ¹⁾	$S_{ m 12HG}$		-35		dB	High gain mode
	$S_{ m 12MG}$		-36		dB	Mid gain mode
	$S_{\sf 12LG}$		-8		dB	Low gain mode
Noise figure	NF_{HG}		1.0		dB	High gain mode
	$N\!F_{MG}$		2.3		dB	Mid gain mode
	NF_{LG}		7.8		dB	Low gain mode
Input return loss ¹⁾	$S_{ ext{11HG}}$		-15		dB	50 Ω, high gain mode
	S_{11MG}		-12		dB	50 Ω, mid gain mode
	$S_{ exttt{11LG}}$		-11		dB	50 Ω, low gain mode
Output return loss ¹⁾	$S_{ m 22HG}$		-19		dB	50 Ω, high gain mode
	$S_{ m 22MG}$		-18		dB	50 Ω, mid gain mode
	$S_{ m 22LG}$		-18		dB	50 Ω, low gain mode
Stability factor ²⁾	k		>2.6			DC to 10 GHz; all gain modes
Input compression point ¹⁾	IP_{1dBHG}		-13		dBm	High gain mode
	IP_{1dBMG}		-13		dBm	Mid gain mode
	IP_{1dBLG}		-7		dBm	Low gain mode
Inband IIP31)	IIP3 _{HG}		-5		dBm	High gain mode
$f_1 - f_2 = 1 \text{ MHz}$	$IIP3_{MG}$		-6			Mid gain mode
$P_{\rm f1}$ = $P_{\rm f2}$ = -26 dBm	IIP3 _{LG}		2			Low gain mode

¹⁾ Verified by random sampling; not 100% RF tested

Data Sheet 12 V2.1, 2008-07-03

²⁾ Not tested in production; guaranteed by device design



Measured RF Characteristics Mid Band

2.10.2 Measured RF Characteristics UMTS Band IV

Table 11 Typical Characteristics 2100 MHz Band, $T_{\rm A}$ = 25 °C, $V_{\rm CC}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

Parameter	Symbol		Values	3	Unit	Note / Test Condition
		Min.	Тур.	Max.		
Pass band range		2110		2155	MHz	
Current consumption	I_{CCHG}		5.30		mA	High gain mode
	I_{CCMG}		5.30		mA	Mid gain mode
	$I_{\mathtt{CCLG}}$		0.85		mA	Low gain mode
Gain	$S_{ m 21HG}$		15.3		dB	High gain mode
	$S_{ m 21MG}$		2.3		dB	Mid gain mode
	$S_{ m 21LG}$		-7.5		dB	Low gain mode
Reverse Isolation ¹⁾	$S_{ m 12HG}$		-34		dB	High gain mode
	S_{12MG}		-35		dB	Mid gain mode
	S_{12LG}		-8		dB	Low gain mode
Noise figure	$N\!F_{HG}$		1.1		dB	High gain mode
	NF_{MG}		2.7		dB	Mid gain mode
	NF_{LG}		7.5		dB	Low gain mode
Input return loss ¹⁾	$S_{ ext{11HG}}$		-19		dB	50 Ω, high gain mode
	S_{11MG}		-14		dB	50 Ω, mid gain mode
	S_{11LG}		-12		dB	50 Ω, low gain mode
Output return loss ¹⁾	$S_{ m 22HG}$		-18		dB	50 Ω, high gain mode
	$S_{ m 22MG}$		-17		dB	50 Ω, mid gain mode
	$S_{ m 22LG}$		-15		dB	50 Ω, low gain mode
Stability factor ²⁾	k		>2.6			DC to 10 GHz; all gain modes
Input compression point ¹⁾	IP_{1dBHG}		-12		dBm	High gain mode
	IP_{1dBMG}		-12		dBm	Mid gain mode
	IP_{1dBLG}		-6		dBm	Low gain mode
Inband IIP3 ¹⁾	IIP3 _{HG}		-5		dBm	High gain mode
$f_1 - f_2 = 1 \text{ MHz}$	$IIP3_{MG}$		-6			Mid gain mode
$P_{\rm f1} = P_{\rm f2} = -26 \text{ dBm}$	$IIP3_{LG}$		2			Low gain mode

¹⁾ Verified by random sampling; not 100% RF tested

Data Sheet 13 V2.1, 2008-07-03

²⁾ Not tested in production; guaranteed by device design



Measured RF Characteristics High Band

2.11 Measured RF Characteristics High Band

2.11.1 Measured RF Characteristics UMTS Band I

Table 12 Typical Characteristics 2100 MHz Band, $T_{\rm A}$ = 25 °C, $V_{\rm CC}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

Parameter	Symbol		Values	5	Unit	Note / Test Condition
		Min.	Тур.	Max.		
Pass band range		2110		2170	MHz	
Current consumption	I_{CCHG}		5.30		mA	High gain mode
	I_{CCMG}		5.30		mA	Mid gain mode
	I_{CCLG}		0.85		mA	Low gain mode
Gain	$S_{ m 21HG}$		16.2		dB	High gain mode
	$S_{21\mathrm{MG}}$		2.3		dB	Mid gain mode
	S_{21LG}		-8.0		dB	Low gain mode
Reverse Isolation ¹⁾	$S_{ m 12HG}$		-35		dB	High gain mode
	$S_{ m 12MG}$		-36		dB	Mid gain mode
	S_{12LG}		-8		dB	Low gain mode
Noise figure	NF_{HG}		1.0		dB	High gain mode
	NF_{MG}		2.6		dB	Mid gain mode
	NF_{LG}		7.9		dB	Low gain mode
Input return loss ¹⁾	S_{11HG}		-13		dB	50 Ω, high gain mode
	S_{11MG}		-12		dB	50 Ω, mid gain mode
	$S_{ m 11LG}$		-10		dB	50 Ω, low gain mode
Output return loss ¹⁾	$S_{ m 22HG}$		-19		dB	50 Ω, high gain mode
	$S_{22\rm MG}$		-24		dB	50 Ω, mid gain mode
	$S_{ m 22LG}$		-14		dB	50 Ω, low gain mode
Stability factor ²⁾	k		>2.2			DC to 10 GHz; all gain modes
Input compression point ¹⁾	IP_{1dBHG}		-13		dBm	High gain mode
	IP_{1dBMG}		-13		dBm	Mid gain mode
	IP_{1dBLG}		-7		dBm	Low gain mode
nband IIP31)	IIP3 _{HG}		-5		dBm	High gain mode
$f_1 - f_2 = 1 \text{ MHz}$	$IIP3_{MG}$		-5			Mid gain mode
$P_{\rm f1}$ = $P_{\rm f2}$ = -27 dBm	$IIP3_{LG}$		2			Low gain mode

¹⁾ Verified by random sampling; not 100% RF tested

Data Sheet 14 V2.1, 2008-07-03

²⁾ Not tested in production; guaranteed by device design

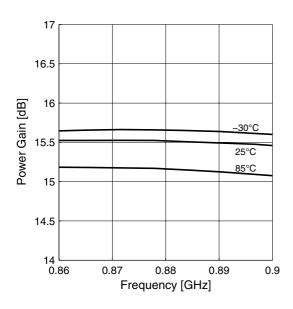


Measured Performance Low Band High Gain Mode vs. Frequency

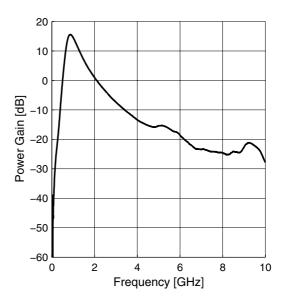
2.12 Measured Performance Low Band High Gain Mode vs. Frequency

 $T_{\rm A}$ = 25 °C, $V_{\rm CC}$ = 2.8 V, $V_{\rm GS1}$ = 2.8 V, $V_{\rm GS2}$ = 0 V, $V_{\rm EN1}$ = 0 V, $V_{\rm EN2}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

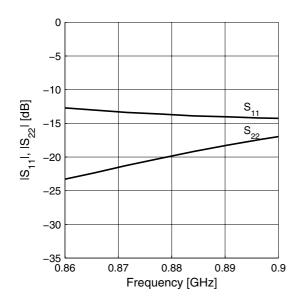
Power Gain $|S_{21}| = f(f)$



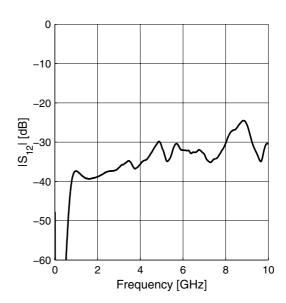
Power Gain Wideband $|S_{21}| = f(f)$



Matching $|S_{11}| = f(f), |S_{22}| = f(f)$



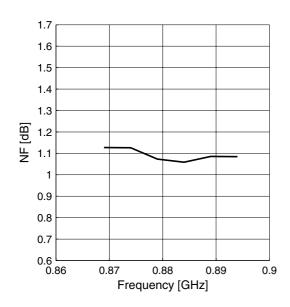
Reverse Isolation $|S_{12}| = f(f)$



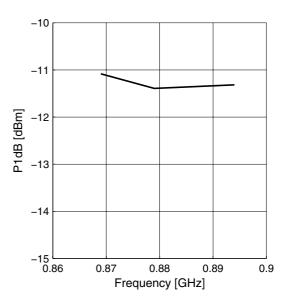


Measured Performance Low Band High Gain Mode vs. Temperature

Noise Figure NF = f(f)



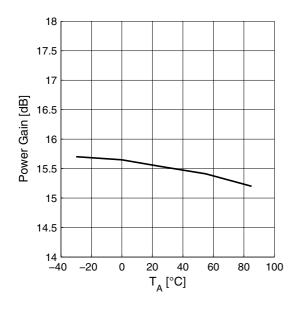
Input Compression $P_{1dB} = f(f)$



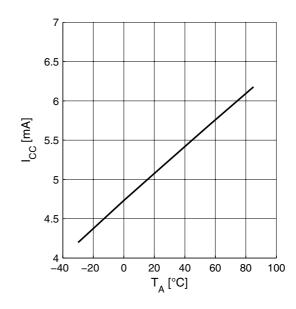
2.13 Measured Performance Low Band High Gain Mode vs. Temperature

$$V_{\rm CC}$$
 = 2.8 V, $V_{\rm GS1}$ = 2.8 V, $V_{\rm GS2}$ = 0 V, $V_{\rm EN1}$ = 0 V, $V_{\rm EN2}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

Power Gain $|S_{21}| = f(T_A)$



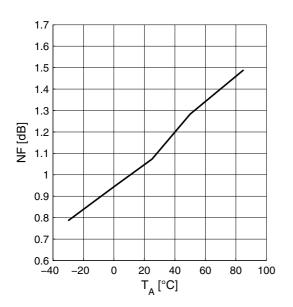
Supply Current $I_{CC} = f(T_A)$



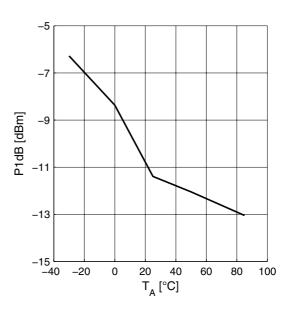


Measured Performance Low Band Mid Gain Mode vs. Frequency

Noise Figure $NF = f(T_A)$



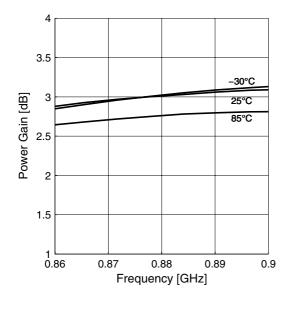
Input Compression $P_{1dB} = f(T_A)$



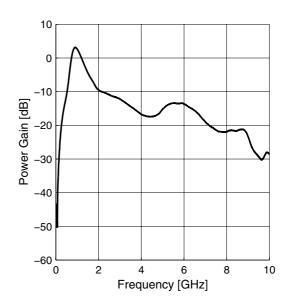
2.14 Measured Performance Low Band Mid Gain Mode vs. Frequency

 $T_{\rm A} = 25~{\rm ^{\circ}C},~V_{\rm CC} = 2.8~{\rm V},~V_{\rm GS1} = 2.8~{\rm V},~V_{\rm GS2} = 2.8~{\rm V},~V_{\rm EN1} = 0~{\rm V},~V_{\rm EN2} = 2.8~{\rm V},~R_{\rm REF} = 8.2~{\rm k}\Omega$

Power Gain $|S_{21}| = f(f)$



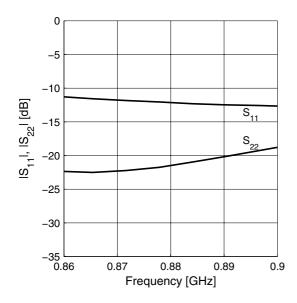
Power Gain Wideband $|S_{21}| = f(f)$



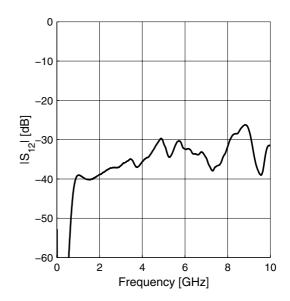


Measured Performance Low Band Mid Gain Mode vs. Frequency

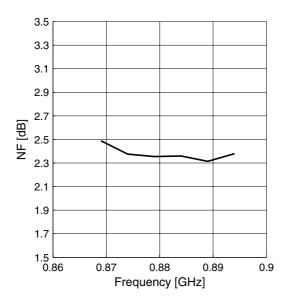
Matching $|S_{11}| = f(f), |S_{22}| = f(f)$



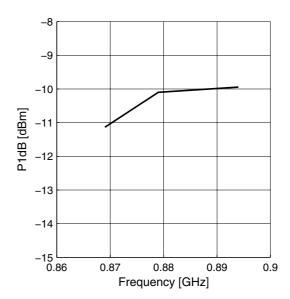
Reverse Isolation $|S_{12}| = f(f)$



Noise Figure NF = f(f)



Input Compression $P_{1dB} = f(f)$



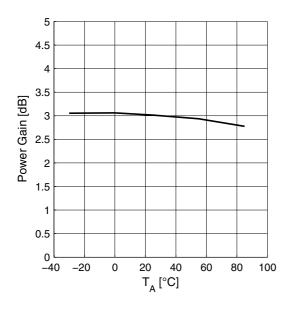


Measured Performance Low Band Mid Gain Mode vs. Temperature

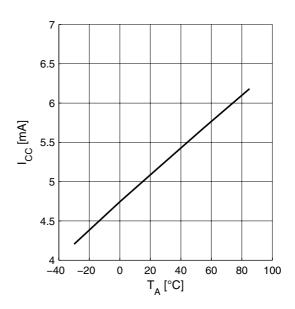
2.15 Measured Performance Low Band Mid Gain Mode vs. Temperature

 $V_{\rm CC}$ = 2.8 V, $V_{\rm GS1}$ = 2.8 V, $V_{\rm GS2}$ = 2.8 V, $V_{\rm EN1}$ = 0 V, $V_{\rm EN2}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

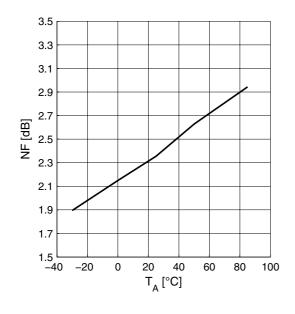
Power Gain $|S_{21}| = f(T_A)$



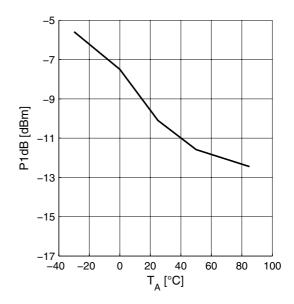
Supply Current $I_{CC} = f(T_A)$



Noise Figure $NF = f(T_A)$



Input Compression P_{1dB} = f(T_{A})



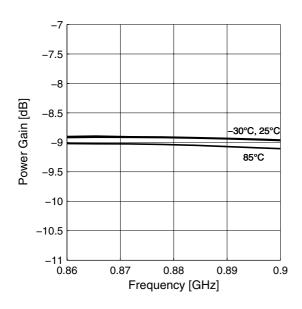


Measured Performance Low Band Low Gain Mode vs. Frequency

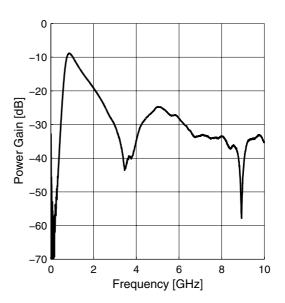
2.16 Measured Performance Low Band Low Gain Mode vs. Frequency

$$T_{\rm A}$$
 = 25 °C, $V_{\rm CC}$ = 2.8 V, $V_{\rm GS1}$ = 0 V, $V_{\rm GS2}$ = 0 V, $V_{\rm EN1}$ = 0 V, $V_{\rm EN2}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

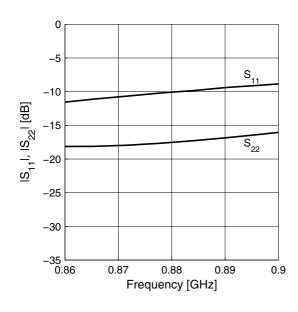
Power Gain $|S_{21}| = f(f)$



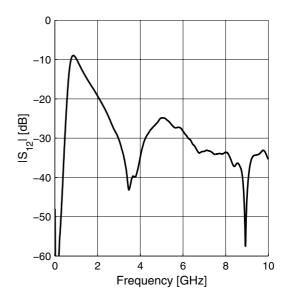
Power Gain Wideband $|S_{21}| = f(f)$



Matching $|S_{11}| = f(f), |S_{22}| = f(f)$



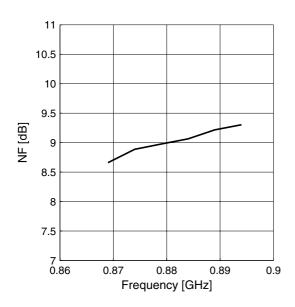
Reverse Isolation $|S_{12}| = f(f)$



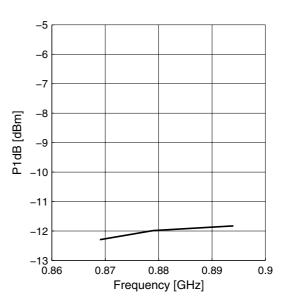


Measured Performance Low Band Low Gain Mode vs. Temperature

Noise Figure NF = f(f)



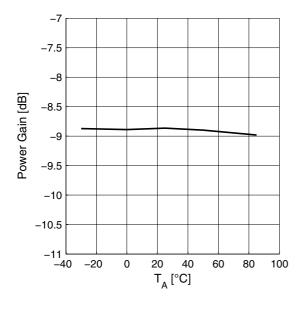
Input Compression $P_{1dB} = f(f)$



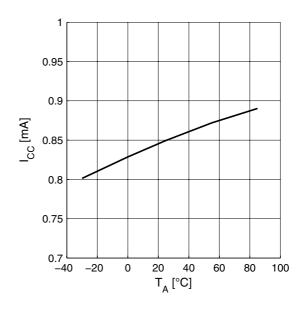
2.17 Measured Performance Low Band Low Gain Mode vs. Temperature

 $V_{\rm CC}$ = 2.8 V, $V_{\rm GS1}$ = 0 V, $V_{\rm GS2}$ = 0 V, $V_{\rm EN1}$ = 0 V, $V_{\rm EN2}$ = 2.8 V, $R_{\rm REF}$ = 8.2 k Ω

Power Gain $|S_{21}| = f(T_A)$



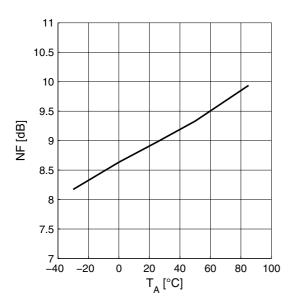
Supply Current I_{CC} = f (T_A)



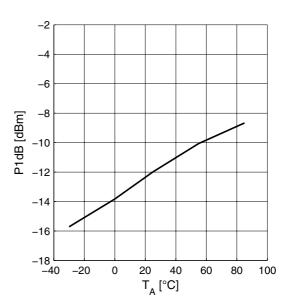


Measured Performance Mid Band High Gain Mode vs. Frequency

Noise Figure $NF = f(T_A)$



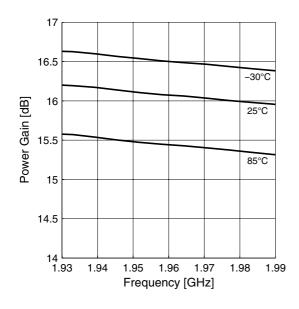
Input Compression $P_{1dB} = f(T_A)$



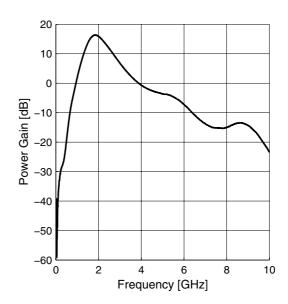
2.18 Measured Performance Mid Band High Gain Mode vs. Frequency

$$T_{\rm A} = 25~{\rm ^{\circ}C},~V_{\rm CC} = 2.8~{\rm V},~V_{\rm GS1} = 2.8~{\rm V},~V_{\rm GS2} = 0~{\rm V},~V_{\rm EN1} = 2.8~{\rm V},~V_{\rm EN2} = 0~{\rm V},~R_{\rm REF} = 8.2~{\rm k}\Omega$$

Power Gain $|S_{21}| = f(f)$



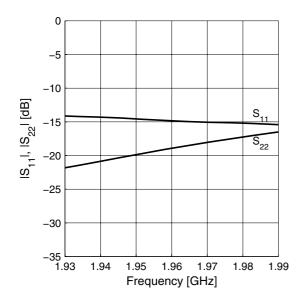
Power Gain Wideband $|S_{21}| = f(f)$



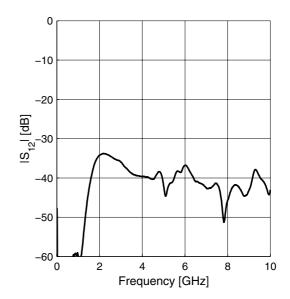


Measured Performance Mid Band High Gain Mode vs. Frequency

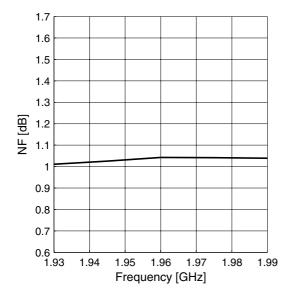
Matching $|S_{11}| = f(f), |S_{22}| = f(f)$



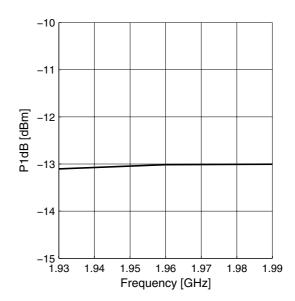
Reverse Isolation $|S_{12}| = f(f)$



Noise Figure NF = f(f)



Input Compression $P_{1dB} = f(f)$



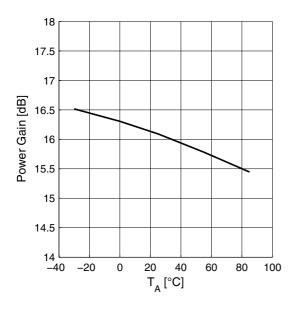


Measured Performance Mid Band High Gain Mode vs. Temperature

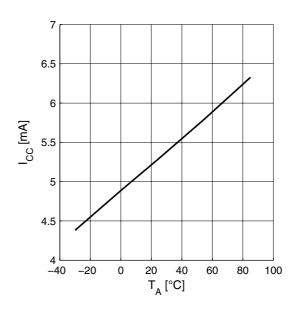
2.19 Measured Performance Mid Band High Gain Mode vs. Temperature

$$V_{\rm CC}$$
 = 2.8 V, $V_{\rm GS1}$ = 2.8 V, $V_{\rm GS2}$ = 0 V, $V_{\rm EN1}$ = 2.8 V, $V_{\rm EN2}$ = 0 V, $R_{\rm REF}$ = 8.2 k Ω

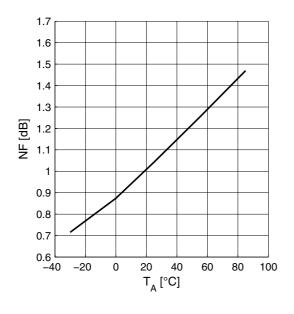
Power Gain $|S_{21}| = f(T_A)$



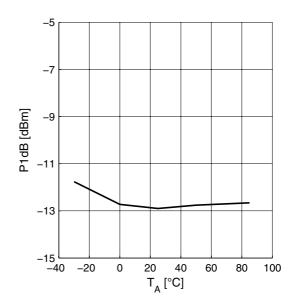
Supply Current $I_{CC} = f(T_A)$



Noise Figure $NF = f(T_A)$



Input Compression P_{1dB} = f(T_{A})



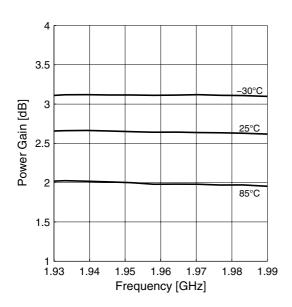


Measured Performance Mid Band Mid Gain Mode vs. Frequency

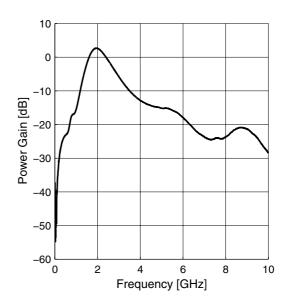
2.20 Measured Performance Mid Band Mid Gain Mode vs. Frequency

 $T_{\rm A} = 25~{\rm ^{\circ}C},~V_{\rm CC} = 2.8~{\rm V},~V_{\rm GS1} = 2.8~{\rm V},~V_{\rm GS2} = 2.8~{\rm V},~V_{\rm EN1} = 2.8~{\rm V},~V_{\rm EN2} = 0~{\rm V},~R_{\rm REF} = 8.2~{\rm k}\Omega$

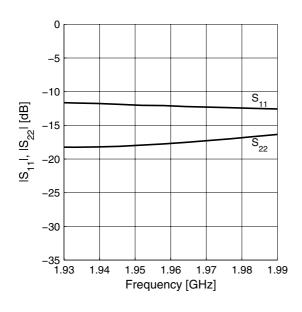
Power Gain $|S_{21}| = f(f)$



Power Gain Wideband $|S_{21}| = f(f)$



Matching $|S_{11}| = f(f), |S_{22}| = f(f)$



Reverse Isolation $|S_{12}| = f(f)$

